

IBMM'98 Presents Exciting Developments in Ion Beam Modification of Materials

The 11th International Conference on Ion Beam Modification of Materials (IBMM) was held in Amsterdam, The Netherlands, from August 31 to September 4, 1998. IBMM is a major international forum to present and discuss recent results and future directions in the field of ion beam modification and formation of new materials. The conference is held every two years in alternating areas around the world, and brings together materials scientists, ion beam specialists, and those interested in practical and industrial applications. IBMM'98 was organized by a team at the FOM-Institute AMOLF, Utrecht University, and Philips Research, chaired by Albert Polman. About 300 participants from nearly 40 countries attended the meeting. Nearly 300 papers were presented in plenary oral sessions as well as poster sessions. IBMM'98 was endorsed by the Materials Research Society.

A wide variety of topics was represented at IBMM'98, including ion beam processing of silicon; phase formations in metals, insulators, or compound semiconductors; ion beam synthesis of optical materials and nanoparticles; ion irradiation effects on organic materials; new ion beam techniques; and the fundamentals of ion beam-solid interactions. Although these topics seem very diverse, the presentations at the conference all shared the use of ion beams. This led to an interesting cross-fertilization between these different fields.

Low-energy cluster beams, ion-assisted deposition, and plasma synthesis were among the highlights in the oral and poster sessions on new techniques and applications of ion beams. Many contributions conveyed that ion beam processing leads to the formation of new and practical materials at a degree of precision and control that cannot be achieved with other methods. Examples that were shown

include the ion beam synthesis of luminescent iron-disilicide, or semiconductor and metallic nanoparticles. A session with great potential technological impact was held on defects, diffusion, and Si technology, in which the application of very low energy ion implantation and the effect of the surface on defects and diffusion kinetics were addressed. Reports on ion beam modification of metals included new developments on magnetic multilayers. Sessions on strain, stress, and plastic flow brought together reports on these topics from different materials fields. With the growing importance of wide bandgap semiconductors, such as GaN, it was interesting to note new ion beam developments in this area. That organic materials are compatible with ion beam processing became clear in sessions that addressed topics such as ion beam microprocessing.

Altogether, IBMM'98 was an exciting conference. The scientific program was complimented with a canal boat tour

through Amsterdam, a conference reception in the historic Maritime museum, and a conference outing in scenic North-Holland. The historic setting of the Royal Tropical Institute Conference Center further stimulated the development of new contacts, collaborations, and friendships between participants from all over the world.

The full IBMM'98 program and abstract book can be found at the IBMM website: <http://www.amolf.nl/ibmm98>, and can be downloaded. A conference proceedings containing around 225 conference papers will be published by Elsevier Science Publishers as a special issue of *Nuclear Instruments and Methods B* in January 1999. For more information contact ibmm98@amolf.nl. The next IBMM conference will be held in September 2000 near Porto Alegre, Brazil, and will be chaired by M. Behar and F.C. Zawislak.

ALBERT POLMAN
IBMM'98 Chair

“Every single atom is an idea, with a story to tell.”

Michael Benedikt
“The Life of Particles”

For **ISO 9000** certification
you need **TRACEABLE**
CALIBRATION standards
for your **METROLOGY**. And
here's the place to get them ↓

Now, get traceable calibration standards and references for Surface Profiling, Film Thickness, Surface Contamination, Surface Characterization, Electrical, and Critical Dimension metrology, and more. Get the free catalog: VLSI Standards, 3087 N. 1st St. San Jose, CA 95134. Phone: (408)428-1800. Fax: (408)428-9555. Web site: www.vlsistd.com

VLSI Standards
Incorporated
The Measurement Standards for the Industry



Materials Research References from Academic Press

Visit Us at MRS
Booth U119
for a 15-50%
Meeting Discount!

SURFACE ACTIVITY

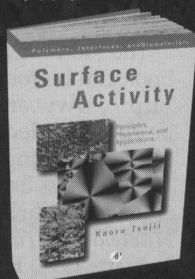
Kaoru Tsujii

A Volume in the
Polymers, Interfaces,
and Biomaterials Series

KEY FEATURES

- Describes surface activity from basic principles to practical applications
- Presents the applications of wetting, foaming and defoaming, emulsions, etc., for detergents, toiletries, cosmetics and other industrial uses
- Describes environmental problems and gives potential future applications for drug delivery systems, sensors, and molecular electronics

April 1998, 245 pp., \$79.00
ISBN: 0-12-702280-5



THEORETICAL AND MATHEMATICAL MODELS IN POLYMER RESEARCH

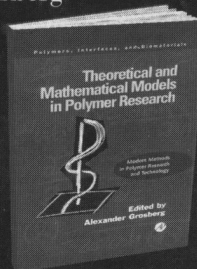
Alexander Yu. Grosberg

A Volume in the
Polymers, Interfaces,
and Biomaterials Series

CONTENTS

Statistical Mechanics of Semiflexible Chains: A Meanfield Variational Approach. Polymer Adsorption: Mean-Field Theory and Ground State Dominance. Approximation. Replica Field Theory Methods in Physics of Polymer Networks. Winding Angle Distributions for Directed Polymers. Bulk and Interfacial Polymer Reaction Kinetics.

March 1998, 283 pp., \$95.00
ISBN: 0-12-304140-6



HANDBOOK OF VACUUM SCIENCE AND TECHNOLOGY

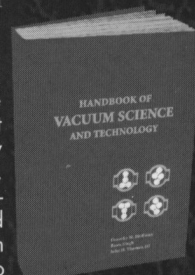
Dorothy M. Hoffman

Bawa Singh

John H. Thomas III

Composed of the latest innovations in vacuum science and technology, this book is aimed at the vacuum practitioner. It covers many of the new vacuum pumps, materials, equipment, and applications. The design and maintenance of modern vacuum systems are also presented.

1997, 835 pp., \$150.00/ISBN: 0-12-352065-7



BIORELATED POLYMERS AND GELS

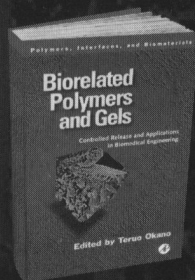
Teruo Okano

A Volume in the
Polymers, Interfaces,
and Biomaterials Series

KEY FEATURES

- One of the first books in this interdisciplinary field
- Describes intelligent materials, including stimuli-responsive polymers and their functions
- Provides a resource-rich discussion of applications

March 1998, 257 pp., \$95.00
ISBN: 0-12-525090-8

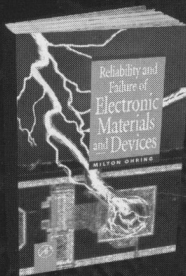


RELIABILITY AND FAILURE OF ELECTRONIC MATERIALS AND DEVICES

Milton Ohring

Readers are introduced to widely dispersed reliability literature of microelectronic devices. Treatment of chip and packaging level failures is integrated within the context of atomic mechanisms and models used to explain degradation, and the statistical handling of lifetime data.

May 1998, 692 pp., \$95.00
ISBN: 0-12-524985-3



UNDERSTANDING MOLECULAR SIMULATION

Daan Frenkel

Berend Smit

1996, 443 pp., \$65.00/ISBN: 0-12-267370-0

HANDBOOK OF OPTICAL CONSTANTS OF SOLIDS FIVE-VOLUME SET

Edited by

Edward D. Palik

Gorachand Ghosh

KEY FEATURES

- Unique source of extremely useful optical data for a very broad community of scientists, researchers, and practitioners
 - Presents optical constants for a broad spectral range and numerous materials
 - Demonstrates various techniques for measuring the optical constants and mathematical models for analytical calculations of data
- 1997, 3440 pp., \$850.00/ ISBN: 0-12-544415-X

Also Available Individually

GIANT MOLECULES

Alexander Yu. Grosberg

Alexei R. Khoklov

The authors take us through the fundamentals of macromolecules in an intuitive and entertaining way.

—EDWIN L. THOMAS in NATURE

1997, 244 pp., \$39.95/ISBN: 0-12-304130-9

THE MATERIALS SCIENCE OF THIN FILMS

Milton Ohring

1991, 750 pp., \$88.00/ISBN: 0-12-524990-X

ENGINEERING MATERIALS SCIENCE

Milton Ohring

1995, 827 pp., \$69.95/ISBN: 0-12-524995-0

INTERMOLECULAR AND SURFACE FORCES, SECOND EDITION

Israelachvili

1991, 480 pp., \$59.00/ISBN: 0-12-375181-0

SECURE ORDERING AVAILABLE ONLINE!

www.academicpress.com

Order from your local bookseller or directly



ACADEMIC PRESS
Order Fulfillment Dept. DM 27098
6277 Sea Harbor Drive, Orlando
FL 32887

In the U.S. and Canada
CALL TOLL FREE: 1-800-321-5068
FAX: 1-800-874-6418
E-MAIL: ap@acad.com

Prices subject to change without notice. ©1998 by Academic Press. All Rights Reserved. KS/SLR/PECS-15118 10/98

Circle No. 4 on Reader Service Card.